

## **TEST REPORT**

Report Number	: ZKT-2312220309E
Date of Test	Dec. 22, 2023 to Dec. 29, 2023
Date of issue	: Dec. 29, 2023
Total number of pages	35
Test Result	: PASS
Testing Laboratory	: Shenzhen ZKT Technology Co., Ltd.
Address	. 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China
Applicant's name	: Zhongshan Yiheng Electrical Equipment Co.,Ltd
Address	. 7th floor, elevator 2, No.1 Fuqing 1st Road, Henglan Town, Zhongshan City
Manufacturer's name	: Zhongshan Yiheng Electrical Equipment Co.,Ltd
Address	. 7th floor, elevator 2, No.1 Fuqing 1st Road, Henglan Town,
Test specification:	
Standard	EN IEC 55014-1:2021, EN IEC 55014-2:2021, EN IEC 61000-3-2:2019/A1:2021, EN 61000-3-3:2013/A2:2021, : EN 61000-4-2:2009, EN IEC 61000-4-3:2020, EN 61000-4-4:2012, EN 61000-4-5:2014+A1:2017, EN IEC 61000-4-6:2023, EN 61000-4-8:2010, EN IEC 61000-4-11:2020
Test procedure	: CE-EMC
Non-standard test method	: N/A
Test Report Form No	: TRF-EL-142_V0
Test Report Form(s) Originator	: ZKT Testing
Master TRF	: Dated: 2020-01-06
This device described above has to test (EUT) is in compliance with the tested sample identified in the report	been tested by ZKT, and the test results show that the equipment under the 2014/30/EU Directive requirements. And it is applicable only to the ort.
This report shall not be reproduced be altered or revised by ZKT, perso	d except in full, without the written approval of ZKT, this document may onal only, and shall be noted in the revision of the document.
Product name	: Water vapor fireplace
Trademark	: N/A
Model/Type reference	: YH-1000S
	YH-800S、YH-1200S、YH-1500S、YH-1800S、YH-2000S
Ratings	: Input: AC 220~240V. 50Hz
	· · ·









#### TABLE OF CONTENT

	Fa
1. VERSION	••••••
2. GENERAL INFORMATION	•••••
2.1 Description of Device (EUT)	
2.2 Tested System Details	
2.3 Test Facility	
2.4 MEASUREMENT UNCERTAINTY	
2.5 Test Instrument Used	
3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST.	
3.1 Block Diagram Of Test Setup	
3.2 Test Standard	
3.3 Power Line Conducted Emission Limit	
3.4 EUT Configuration on Test	
3.5 Operating Condition of EUT	
3.6 Test Procedure	
	1
	1
4.1 Block Diagram of Test Setup	l
4.2 Test Standard	I 1
4.5 Radiation Linit	1 1
4.5 Operating Condition of EUT	
4.6 Test Procedure	
4.7 Test Result	
5. HARMONIC CURRENT EMISSION TEST	
5 1 Block Diagram of Test Setup	1
5.2 Test Standard	
5.3 Operating Condition of EUT	
5.4 Test Procedure	
5.5 Test Results	1
6. VOLTAGE FLUCTUATIONS & FLICKER TEST	1
6.1 Block Diagram of Test Setup	
6.2 Test Standard	
6.3 Operating Condition of EUT	
6.4 Test Procedure	1
6.5 Test Results	1
7. ELECTROSTATIC DISCHARGE IMMUNITY TEST	2
7.1 Block Diagram of Test Setup	2
7.2 Test Standard	
7.3 Severity Levels and Performance Criterion	
7.4 EUT Configuration	2
7.5 Operating Condition of EUT	
7.6 Test Procedure	2 د
	2
8. RF FIELD STRENGTH SUSCEPTIBILITY TEST	
8.1 Block Diagram of Test Setup	2
8.2 Iest Standard	
8.4 EUT Configuration on Test	
8.5 Operating Condition of FUT	2 ว
8.6 Test Procedure	
8.7 Test Results	
hen ZKT Technology Co. Ltd	



9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST	. 26
9.1 Block Diagram of EUT Test Setup	26
9.2 Test Standard	26
9.3 Severity Levels and Performance Criterion	26
9.4 EUT Configuration on Test	27
9.5 Operating Condition of EUT	27
9.6 Test Procedure	27
9.7 Test Results	27
10. SURGE TEST	. 28
10.1 Block Diagram of EUT Test Setup	28
10.2 Test Standard	28
10.3 Severity Levels and Performance Criterion	28
10.4 EUT Configuration on Test	29
10.5 Operating Condition of EUT	29
10.6 Test Procedure	29
10.7 Test Result	29
11. INJECTED CURRENTS SUSCEPTIBILITY TEST	30
11.1 Block Diagram of EUT Test Setup	30
11.2 Test Standard	30
11.3 Severity Levels and Performance Criterion	30
11.4 EUT Configuration on Test	30
11.5 Operating Condition of EUT	30
11.6 Test Procedure	31
11.7 Test Result	31
12. VOLTAGE DIPS AND INTERRUPTIONS TEST	. 32
12.1 Block Diagram of EUT Test Setup	32
12.2 Test Standard	32
12.3 Severity Levels and Performance Criterion	32
12.4 EUT Configuration on Test	32
12.5 Operating Condition of EUT	32
12.6 Test Procedure	33
12.7 Test Result	33
13. EUT PHOTOGRAPHS	. 34
14. EUT TEST PHOTOGRAPHS	.35





#### 1. VERSION

	Report No.	Version	Description	Approved
	ZKT-2312220309E	Rev.01	Initial issue of report	Dec. 29, 2023
T				















Site Location

1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

#### 2.4 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test item	Value (dB)
Conducted Emission (150K-30MHZ)	3.20
Radiated disturbance30MHz-1000MHz	4.80

Please refer to the following page.





#### 2.5 Test Instrument Used

#### Conducted emissions & Magnetic Emission & Disturbance power Test

ltem	Kind of Equipment	Manufacturer	Type No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	LISN	R&S	ENV216	101471	N/A	Nov. 14, 2023	Nov. 13, 2024
2	LISN	CYBERTEK	EM5040A	E1850400149	N/A	Nov. 02, 2023	Nov. 01, 2024
3	Test Cable	N/A	C-01	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
4	Test Cable	N/A	C-02	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
5	Test Cable	N/A	C-03	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
6	EMI Test Receiver	R&S	ESCI3	101393	4.42 SP3	Nov. 02, 2023	Nov. 01, 2024
7	Triple-Loop Antenna	N/A	RF300	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
8	Absorbing Clamp	DZ	ZN23201	15034	N/A	Nov. 07, 2023	Nov. 06, 2024
9	EMC Software	Frad	EZ-EMC	Ver.EMC-CO N 3A1.1	N/A	١	Ι

#### Harmonic / Flicker Test

Item	Kind of Equipment	Manufacturer	Туре No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	Harmonic & Flicker	HTEC Instruments	AC2000A	548549	1.21	Nov. 02, 2023	Nov. 01, 2024
2	AC Power Source	1	HPHF4010	JN102209079 5	DAL40	Nov. 02, 2023	Nov. 01, 2024

	Electrostatic disch	arge Test					
ltem	Kind of Equipment	Manufacturer	Type No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	ESD TEST GENERATOR	HTEC	HESD16	N/A	004307	Nov. 08, 2023	Nov. 07, 2024

#### EFT and Surge and Voltage dips and interruptions Test

GuoRenTong

Item	Kind of Equipment	Manufacturer	Туре No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	Surge Generator	HTEC	HCOMPACT 5	N/A	V1.3.4	Nov. 02, 2023	Nov. 01, 2024
2	DIPS Generator	HTEC	HV1P16T	202101	V1.3.4	Nov. 02, 2023	Nov. 01, 2024
3	EFT/B Generator	HTEC	HCOMPACT 5	N/A	V1.3.4	Nov. 02, 2023	Nov. 01, 2024
4	EFT/B Clamp	HTEC	H3C	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024

#### For Magnetic Field Immunity Test

Item	Kind of Equipment	Manufacturer	Туре No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	Generator	HTEC	HFMG 100	202602	V2.1-182802	Nov. 02, 2023	Nov. 01, 2024

#### Radio-frequency fields Immunity Test Kind of Firmware Item Manufacturer Type No. Serial No. Last calibration Equipment Version 1 Signal Generator TESEQ NSG4070-75 31477 V1.30 Nov. 02, 2023 CDN M2/M3PE 2 SCHWARZBECK CDN 00128 N/A Nov. 02, 2023 16A

SGR-SJQ-6dB-

DC-3

Shenzhen ZKT Technology Co., Ltd.

1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

N/A

Attenuator

3

N/A



Nov. 02, 2023

Calibrated until

Nov. 01, 2024

Nov. 01, 2024

Nov. 01, 2024



#### Radiation Test equipment

Item	Equipment	Manufactur er	Type No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	Spectrum Analyzer (9kHz-26.5GHz)	KEYSIGHT	9020A	MY5537083 5	A.17.05	Nov. 02, 2023	Nov. 01, 2024
2	Spectrum Analyzer (10kHz-39.9GHz)	R&S	FSV40-N	100363	1.71 SP2	Nov. 02, 2023	Nov. 01, 2024
3	EMI Test Receiver (9kHz-7GHz)	R&S	ESCI7	100969	4.32	Nov. 02, 2023	Nov. 01, 2024
4	Bilog Antenna (30MHz-1500MHz)	Schwarzbec k	VULB9168	N/A	N/A	Nov. 13, 2023	Nov. 12, 2024
5	Horn Antenna (1GHz-18GHz)	Agilent	AH-118	071145	N/A	Nov. 13, 2023	Nov. 12, 2024
6	Horn Antenna (15GHz-40GHz)	A.H.System	SAS-574	588	N/A	Nov. 13, 2023	Nov. 12, 2024
7	Loop Antenna	TESEQ	HLA6121	58357	N/A	Nov. 16, 2023	Nov. 15, 2024
8	Amplifier (30-1000MHz)	EM Electronics	EM330 Amplifier	60747	N/A	Nov. 02, 2023	Nov. 01, 2024
9	Amplifier (1GHz-26.5GHz)	HuiPu	8449B	3008A00315	N/A	Nov. 02, 2023	Nov. 01, 2024
10	Amplifier (500MHz-40GHz)	QuanJuDa	DLE-161	097	N/A	Nov. 02, 2023	Nov. 01, 2024
11	Test Cable	N/A	R-01	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
12	Test Cable	N/A	R-02	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
13	Test Cable	N/A	R-03	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
14	Test Cable	N/A	RF-01	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
15	Test Cable	N/A	RF-02	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
16	Test Cable	N/A	RF-03	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
17	ESG Signal Generator	Agilent	E4421B	N/A	B.03.84	Nov. 02, 2023	Nov. 01, 2024
18	Signal Generator	Agilent	N5182A	N/A	A.01.87	Nov. 02, 2023	Nov. 01, 2024
19	Magnetic Field Probe Tester	Narda	ELT-400	0-0344	N/A	Nov. 16, 2023	Nov. 15, 2024
20	Wideband Radio Communication Test	R&S	CMW500	106504	V 3.7.22	Nov. 02, 2023	Nov. 01, 2024
21	MWRF Power Meter Test system	MW	MW100-RF CB	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
22	D.C. Power Supply	LongWei	TPR-6405D	N/A	N/A	Λ.	λ
23	EMC Software	Frad	EZ-EMC	Ver.EMC-C ON 3A1.1	N/A	١	١
24	RF Software	MW	MTS8310	V2.0.0.0	N/A	N	Ν
25	Turntable	MF	MF-7802BS	N/A	N/A	λ	١
26	Antenna tower	MF	MF-7802BS	N/A	N/A		\



#### 3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

#### 3.1 Block Diagram Of Test Setup



#### 3.2 Test Standard

#### EN IEC 55014-1:2021

#### 3.3 Power Line Conducted Emission Limit

Frequency	Limits dB(μV)			
MHz	Quasi-peak Level	Average Level		
0.15 ~ 0.50	66 ~ 56*	59 ~ 46*		
0.50 ~ 5.00	56	46		
5.00 ~ 30.00	60	50		

Notes: 1. \*Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

#### 3.4 EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN 55014-1 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

#### 3.5 Operating Condition of EUT

3.5.1 Setup the EUT and simulators as shown in Section 3.1. 3.5.2 Turn on the power of all equipments.

3.5.3 Let the EUT work in test modes and test it.

#### 3.6 Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **EN55014-1** regulations during conducted emission test.

The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

The frequency range from 150 KHz to 30 MHz is investigated.

#### 3.7 Test Result

#### Pass

Please refer to the following page.

Shenzhen ZKT Technology Co., Ltd

1/F, No. 101, Building B, No. 6, Tangwel Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China



Conducted Emission At The Mains Terminals Test Data								
Temperature:	<b>26</b> ℃	Relative Humidity:	60%					
Pressure:	1009hPa	Phase :	Line					
Test Voltage :	AC 230V 50Hz	Test Mode:	Working					



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1860	25.07	12.23	37.30	64.21	-26.91	QP	P	
2	0.1860	15.48	12.23	27.71	56.68	-28.97	AVG	P	
3	0.2220	15.62	11.82	27.44	54.77	-27.33	AVG	Р	
4	0.2265	26.31	11.80	38.11	62.58	-24.47	QP	Р	
5	0.3120	14.50	11.41	25.91	51.09	-25.18	AVG	P	
6	0.3209	25.35	11.37	36.72	59.68	-22.96	QP	Р	
7	0.3975	24.58	11.01	35.59	57.91	-22.32	QP	Р	
8	0.4065	14.26	10.97	25.23	48.24	-23.01	AVG	Р	
9	0.6269	24.50	10.51	35.01	56.00	-20.99	QP	Р	
10	0.6269	13.00	10.51	23.51	46.00	-22.49	AVG	Р	
11	1.3919	16.48	10.34	26.82	46.00	-19.18	AVG	Р	
12	1.3964	26.10	10.34	36.44	56.00	-19.56	QP	Р	





Conducted Emission At The Mains Terminals Test Data								
Temperature:	<b>26°</b> ℃	Relative Humidity:	60%					
Pressure:	1009hPa	Phase :	Neutral					
Test Voltage :	AC 230V 50Hz	Test Mode:	Working					



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1545	23.26	12.91	36.17	65.75	-29.58	QP	Р	
2	0.1545	12.77	12.91	25.68	58.68	-33.00	AVG	P	
3	0.1815	15.04	12.33	27.37	56.94	-29.57	AVG	Р	
4	0.1860	25.29	12.23	37.52	64.21	-26.69	QP	P	
5	0.2175	26.06	11.84	37.90	62.91	-25.01	QP	P	
6	0.2220	15.74	11.82	27.56	54.77	-27.21	AVG	Р	
7	0.2490	26.41	11.69	38.10	61.79	-23.69	QP	Р	
8	0.2490	16.06	11.69	27.75	53.53	-25.78	AVG	Р	
9	0.3075	26.75	11.43	38.18	60.04	-21.86	QP	Р	
10	0.3075	14.99	11.43	26.42	51.25	-24.83	AVG	Р	
11	1.3695	16.24	10.35	26.59	46.00	-19.41	AVG	Р	
12	1.3740	26.00	10.35	36.35	56.00	-19.65	QP	P	







#### 4. RADIATION EMISSION TEST

4.1 Block Diagram of Test Setup

#### Antenna Tower



#### 4.2 Test Standard

EN IEC 55014-1:2021

4.3 Radiation Limit

Frequ M⊦	ency Iz	Distance (Meters)	Field Strengths Limits dB(μV)/m
$30$ $\sim$	230	3	40.0
230 $\sim$	1000	3	47.0

#### Remark:

(1) Emission level (dB( $\mu$ V)/m) = 20 log Emission level ( $\mu$ V/m)

(2) The smaller limit shall apply at the cross point between two frequency bands.

(3) Distance refers to the distance in meters between the measuring instrument, antenna and the closed point of any part of the device or system.

#### 4.4 EUT Configuration on Test

The EN 55014-1 regulations test method must be used to find the maximum emission during radiated emission test. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.2.

#### 4.5 Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.2 except the test set up replaced as Section 4.1.

## Shenzhen ZKT Technology Co., Ltd.

1/F, No. 101, Building B, No. 6, Tangwel Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China





#### 4.6 Test Procedure

The EUT and its simulators are placed on a turned table that is 0.8 meter above the ground. The turned table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna that is mounted on the antenna tower. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) is used as receiving antenna. Both horizontal and vertical polarization of the antenna is set on test. In order to find the maximum emission levels, the interface cable must be manipulated according to EN 55014-1 on radiated emission test.

The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz.

The frequency range from 30MHz to 1000MHz is checked.

#### 4.7 Test Result

Pass Please refer to the following page.











Radiation Emission Test Data									
Temperature:	<b>23.8</b> ℃	Relative Humidity:	42%						
Pressure:	1009hPa	Phase :	Horizontal						
Test Voltage :	AC 230V 50Hz	Test Mode:	Working						



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	49.4460	47.65	-17.27	30.38	40.00	-9.62	QP				
2	171.6933	50.01	-19.98	30.03	40.00	-9.97	QP				
3	177.8206	45.62	-19.88	25.74	40.00	-14.26	QP				
4	217.5443	46.07	-20.43	25.64	40.00	-14.36	QP				
5	645.1194	29.74	-7.72	22.02	47.00	-24.98	QP				
6	924.1345	29.78	-0.61	29.17	47.00	-17.83	QP				

![](_page_13_Picture_10.jpeg)

![](_page_14_Picture_0.jpeg)

![](_page_14_Picture_1.jpeg)

Radiation Emission Test Data									
Temperature:	<b>23.8℃</b>	Relative Humidity:	42%						
Pressure:	1009hPa	Phase :	Vertical						
Test Voltage :	AC 230V 50Hz	Test Mode:	Working						

![](_page_14_Figure_4.jpeg)

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	131.9889	43.16	-17.59	25.57	40.00	-14.43	QP				
2	171.6933	44.90	-17.15	27.75	40.00	-12.25	QP				
3	217.5443	45.59	-17.92	27.67	40.00	-12.33	QP				
4	250.3011	42.37	-15.90	26.47	47.00	-20.53	QP				
5	280.5152	38.71	-14.41	24.30	47.00	-22.70	QP				
6	334.2722	40.06	-16.84	23.22	47.00	-23.78	QP				

![](_page_14_Picture_10.jpeg)

![](_page_15_Picture_0.jpeg)

#### 5. HARMONIC CURRENT EMISSION TEST

5.1 Block Diagram of Test Setup

![](_page_15_Figure_4.jpeg)

#### 5.2 Test Standard

EN IEC 61000-3-2:2019/A1:2021

#### 5.3 Operating Condition of EUT

5.3.1 Setup the EUT as shown in Section 5.1.

5.3.2 Turn on the power of all equipments.

5.3.3 Let the EUT work in test mode and test it.

#### 5.4 Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

#### 5.5 Test Results

Pass Please refer to the following page.

![](_page_15_Picture_15.jpeg)

![](_page_15_Picture_19.jpeg)

![](_page_16_Picture_0.jpeg)

![](_page_16_Picture_1.jpeg)

![](_page_16_Picture_2.jpeg)

Shenzhen ZKT Technology Co., Ltd. 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

![](_page_16_Picture_7.jpeg)

Project No.: ZKT-2312220309E Page 17 of 35

![](_page_17_Picture_1.jpeg)

N	Filtered	Limit	Avg.	%Limit	Max.	%Limit		N	Filtered	Limit	Avg.	%Limit	Max.	%Limi	1
1	446.7	2		1		1.22	1	2	2.3	1080.0	2.5	0.2	2.8	0.3	1
3	411.8	2300.0	411.3	17.9	411.8	17.9	1	4	2.3	430.0	2.4	0.6	2.6	0.6	1
5	366.4	1140.0	366.0	32.1	366.6	32.2	1	6	2.3	300.0	2.5	0.8	2.6	0.9	1
7	306.9	770.0	306.5	39.8	307.3	39.9	~	8	2.1	230.0	2.6	1.1	2.8	1.2	1
9	241.3	400.0	241.0	60.3	241.8	60.5	1	10	2.3	184.0	2.6	1.4	3.0	1.6	1
11	179.6	330.0	179.3	54.3	180.1	54.6	1	12	2.5	153.3	2.7	1.8	3.0	2.0	1
13	130.7	210.0	130.4	62.1	131.0	62.4	1	14	2.5	131.4	2.8	2.1	3.2	2.4	1
15	101.6	150.0	101.2	67.5	101.7	67.8	1	16	2.5	115.0	2.8	2.4	3.2	2.8	1
17	89.7	132.3	89.4	67.6	90.0	68.0	1	18	2.5	102.2	2.8	2.7	3.2	3.1	1
19	84.3	118.4	84.0	70.9	84.5	71.4	1	20	2.5	92.0	2.7	2.9	3.2	3.5	1
21	76.9	107.1	76.7	71.6	77.3	72.2	1	22	2.6	83.6	2.7	3.2	3.0	3.6	1
23	66.8	97.8	66.7	68.2	67.0	68.5	1	24	2.5	76.7	2.6	3.4	3.0	3.9	1
25	56.6	90.0	56.4	62.7	56.8	63.1	1	26	2.5	70.8	2.5	3.5	2.8	4.0	1
27	49.2	83.3	49.0	58.8	49.4	59.3	1	28	2.5	65.7	2.5	3.8	2.8	4.3	1
29	45.3	77.6	45.0	58.0	45.4	58.5	1	30	2.3	61.3	2.4	3.9	2.6	4.2	1
31	42.6	72.6	42.4	58.4	42.7	58.8	1	32	1.9	57.5	2.1	3.7	2.5	4.3	1
33	39.0	68.2	38.7	56.7	39.0	57.2	1	34	1.7	54.1	2.0	3.7	2.3	4.3	1
35	34.1	64.3	33.9	52.7	34.1	53.0	1	36	1.6	51.1	1.8	3.5	2.1	4.1	1
37	29.3	60.8	29.1	47.9	29.3	48.2	1	38	1.4	48.4	1.6	3.3	1.9	3.9	1
39	25.7	57.7	25.5	44.2	25.7	44.5	1	40	1.4	46.0	1.6	3.5	1.7	3.7	1
P	155.3	251.4	154.5	61.5	155.5	61.9	1					4		1223	

![](_page_17_Picture_3.jpeg)

![](_page_17_Picture_4.jpeg)

![](_page_17_Picture_5.jpeg)

![](_page_17_Picture_6.jpeg)

![](_page_18_Picture_0.jpeg)

![](_page_18_Picture_2.jpeg)

#### 6. VOLTAGE FLUCTUATIONS & FLICKER TEST

#### 6.1 Block Diagram of Test Setup

Same as Section 6.1.

#### 6.2 Test Standard

EN 61000-3-3:2013/A2:2021

#### 6.3 Operating Condition of EUT

Same as Section 5.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

#### Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
Tmax	4.0%
dt	Not exceed 3.3% for 500ms

#### 6.4 Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

#### 6.5 Test Results

PASS

Flicker Test Data									
Temperature:	<b>26</b> ℃	Relative Humidity:	60%						
Pressure:	1009hPa	Phase :	Vertical						
Test Voltage :	AC 230V 50Hz	Test Mode:	Working						

the second se		
Voltage Fluctuation	Limit	Value
Relative Voltage Change Characteristic Tmax (dc>3.3%)	500 ms	0 ms
Maximum Relative Voltage Change dmax	4%	0.00
	6%	/
	7%	1
Relative Steady-state Voltage Change dc	3.3%	0.00
Flicker	Limit	Value

![](_page_18_Picture_18.jpeg)

Shenzhen ZKT Technology Co., Ltd.

1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

![](_page_18_Picture_24.jpeg)

![](_page_19_Picture_0.jpeg)

#### 7. ELECTROSTATIC DISCHARGE IMMUNITY TEST

![](_page_19_Figure_3.jpeg)

![](_page_19_Figure_4.jpeg)

#### 7.2 Test Standard

EN IEC 55014-2:2021, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge:±8KV Level: 2 / Contact Discharge:±4KV

7.3 Severity Levels and Performance Criterion

![](_page_19_Picture_9.jpeg)

7.3.1	Severity	level
1.0.1	Covering	10101

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
Х	Special	Special

7.3.2 Performance criterion : B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- **B.** The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- **C.** Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

![](_page_19_Picture_20.jpeg)

![](_page_20_Picture_0.jpeg)

![](_page_20_Picture_1.jpeg)

#### 7.4 EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet EN IEC 55014-2:2021, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.4.

#### 7.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

#### 7.6 Test Procedure

#### 7.6.1 Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 7.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

7.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

#### 7.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

#### 7.7 Test Results

PASS Please refer to the following page.

![](_page_20_Picture_17.jpeg)

![](_page_20_Picture_18.jpeg)

Shenzhen ZKT Technology Co., Ltd. 1/F, No. 101, Building B, No. 6, Tangwel Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

www.zkt-lab.com

![](_page_21_Picture_0.jpeg)

![](_page_21_Picture_1.jpeg)

	ES	D Te	est Data		
Temperature:	Temperature:26°CHumidity:				60%
Power Supply :	AC 230V 50Hz		Test Mode:	W	orking
Air Discharge: ± 8KV Contact Discharge: ±	4KV				
Test Points	Air Discharge	С	ontact Discharge	Performance Criterion	Result
Enclosure	±2,4,8KV		N/A	В	PASS
Slit	±2,4,8KV		N/A	В	PASS
Metal Part	N/A		±2,4 KV	В	PASS
VCP	N/A		±2,4 KV	В	PASS
HCP	N/A		±2,4 KV	В	PASS

Note: N/A

![](_page_22_Picture_0.jpeg)

+86-400-000-9970

+86-755-2233 6688

Www.zkt-lab.com

![](_page_23_Picture_0.jpeg)

#### 8.3.2. Performance criterion: A

![](_page_23_Picture_3.jpeg)

The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i

- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

#### 8.4 EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN IEC 55014-2:2021, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

#### 8.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.5 except the test setup replaced by Section 8.1.

#### 8.6 Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

#### All the scanning conditions are as follows : Condition of Test

- 1. Fielded Strength
- Radiated Signal
  Scanning Freque
- Scanning Frequency
  Dwell time of radiated
- 4. Dwell time of radiate
- 5. Waiting Time

#### 8.7 Test Results

PASS Please refer to the following page.

Remarks

3 V/m (Severity Level 2) Modulated 80 – 1000 MHz 0.0015 decade/s 1 Sec.

B

R

Shenzhen ZKT Technology Co., Ltd.

1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

www.zkt-lab.com

![](_page_24_Picture_0.jpeg)

![](_page_24_Picture_1.jpeg)

Pass

Pass

	R/S 1	Test Data		
Temperature : 26℃		Humi	idity:60%	212
Field Strength: 3 V/m		Criter	rion: A	
Power Supply: AC 230	/ 50Hz	Frequ	uency Range:	80 MHz to 1000 MHz
Modulation:	AM Dulse	□none	1 KHz 80%	
Test Mode : On			1	
	Frequency Range : 8	80-1000MH	Ηz	
Steps	1 %			
	Horizontal		Vertical	Result
Front	A		A	Pass
Right	A		A	Pass

А

Α

Note: The EUT is the testing item(s) was (were) fulfilled by subcontracted lab SHENZHEN HAIYUN TESTING CO.,LTD

А

Α

Rear

Left

![](_page_24_Picture_5.jpeg)

![](_page_25_Picture_0.jpeg)

![](_page_25_Picture_2.jpeg)

#### 9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1 Block Diagram of EUT Test Setup

![](_page_25_Figure_5.jpeg)

9.2 Test Standard

EN IEC 55014-2:2021, EN 61000-4-4:2012

#### 9.3 Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS Severity Level:

Open Circuit Output Test Voltage ±10%						
Level	On power ports	On I/O(Input/Output) Signal data and control ports				
1.	0.5KV	0.25KV				
2.	1KV	0.5KV				
3.	2KV	1KV				
4.	4KV	2KV				
Χ.	Special	Special				

#### Performance criterion: B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

![](_page_25_Picture_19.jpeg)

![](_page_26_Picture_0.jpeg)

![](_page_26_Figure_2.jpeg)

#### 9.4 EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN IEC 55014-2:2021, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

#### 9.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 9.1.

#### 9.6 Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m\*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

#### 9.7 Test Results

#### PASS

Please refer to the following page

		EFT	Test Data			
Temperature:	<b>26</b> ℃	Humidity: 60%				
Power Supply :	AC 230V 50Hz	Т	est Mode:	Wo	orking	
		- 0				$\sim$
	Test V	/oltage	e		Performance	Result
Coupling Line	±0.5kV		±1kV		Criterion	
L	±0.5kV		±1kV		В	PASS
Ν	±0.5kV		±1kV		В	PASS
L-N	±0.5kV		±1kV		В	PASS
DC Line	1		/			/
Note: N/A		Q	S		·	22

Shenzhen ZKT Technology Co., Ltd

1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

![](_page_27_Picture_0.jpeg)

Severity Level	Open-Circuit Test Voltage (KV)	1.0
1.	0.5	
2.	1.0	
3.	2.0	
4.	4.0	
Χ.	Special	

Performance criterion: B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

![](_page_28_Picture_0.jpeg)

#### 10.4 EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN IEC 55014-2:2021, EN61000-4-5:2014+A1:2017, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

#### 10.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 10.1.

#### 10.6 Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- 6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

#### 10.7 Test Result

#### PASS

Surge Test Data									
Temperature:			<b>26</b> ℃		ŀ	lumidity:		60%	
Power Supp	oly :		AC 230V 50H	z	Те	est Mode:		Working	
Location	Polari	ty	Phase Angle	No of	Pulse	Pulse Voltage (KV)	e Perl C	formance riterion	Result
	+		90	5		1			Pass
L NI	-		90	5	1	D	Pass		
L-IN	+		270	5	1		D	Pass	
			270	5		1			Pass
Note: N/A	Note: N/A								

![](_page_28_Picture_19.jpeg)

![](_page_28_Picture_20.jpeg)

![](_page_28_Picture_21.jpeg)

![](_page_28_Picture_24.jpeg)

![](_page_29_Picture_0.jpeg)

![](_page_29_Figure_3.jpeg)

![](_page_29_Figure_4.jpeg)

11.2 Test Standard

EN IEC 55014-2:2021, EN IEC 61000-4-6:2023

#### 11.3 Severity Levels and Performance Criterion

Severity Level 2: 3V( rms ), 150KHz  $\,\sim\,$  80MHz Severity Level:

Level	Field Strength V
1.	1
2.	3
3.	10
Χ.	Special

#### Performance criterion: A

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

#### 11.4 EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.8.

#### 11.5 Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 11.1.

![](_page_29_Picture_22.jpeg)

![](_page_30_Picture_0.jpeg)

#### 11.6 Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
  - 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
  - 4) The disturbance signal described below is injected to EUT through CDN.
  - 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
  - 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave
  - 7) The rate of sweep shall not exceed 1.5×10<sup>-3</sup> decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
  - 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

#### 11.7 Test Result

#### PASS

CS Test Data								
Tempera	ature:	2	26℃	Humidity: 60%			0%	
Power Sup	oply :	AC 23	30V 50Hz	Test Mod	de:	Working		
Frequency Range(MHz)	Injected Position	Strength	Modulation Signal	Freq. Step	Freq. Perfor Step Crit		Result	
$150  ext{KHz} \sim 80  ext{MHz}$	AC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	%		Pass	
$150  ext{KHz} \sim 80  ext{MHz}$	DC Line	1V(rms), Unmodulated	rms), AM 80%, 1kHz dulated sine wave 1%			/	/	
Note: N/A	Note: N/A							

![](_page_30_Picture_18.jpeg)

![](_page_31_Picture_1.jpeg)

### 12.1 Block Diagram of EUT Test Setup

![](_page_31_Figure_3.jpeg)

#### 12.2 Test Standard

EN IEC 55014-2:2021, EN IEC 61000-4-11:2020

#### 12.3 Severity Levels and Performance Criterion

#### Severity Level:

Input and Output AC Power Ports.

Voltage Interruptions.

Voltage Dips.

⊻

Environmental **Test Specification** Units Performance Phenomena Criterion 70 % Reduction С 25 period Voltage Dips 40 % Reduction С 10 period Voltage Interruptions 0 % Reduction С 0.5 period

![](_page_31_Picture_11.jpeg)

# Ð

#### Performance criterion: B, C, C

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

#### 12.4 EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.10.

#### 12.5 Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.10 except the test set up replaced as Section 13.1.

![](_page_32_Picture_0.jpeg)

![](_page_32_Picture_1.jpeg)

#### 12.6 Test Procedure

- 1) Set up the EUT and test generator as shown on section 13.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

#### 12.7 Test Result

#### PASS

Please refer to the following page.

		DIPS Test Data				
	Temperature:	<b>26</b> ℃	°C Humidity: 60%			
-	Power Supply :	AC 230V 50Hz	Test Mode:	Working		
	Environmental Phenomena	Environmental Phenomena Test Specification		Performance Criterion		
		70 25	% Reduction period	С		
	voltage Dips	40 10	% Reduction period	С		
	Voltage Interruptions	0 0.5	% Reduction period	С		

![](_page_32_Picture_13.jpeg)

Shenzhen ZKT Technology Co., Ltd. 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

旦,

![](_page_32_Picture_18.jpeg)

![](_page_33_Picture_0.jpeg)

![](_page_33_Picture_1.jpeg)

## **13. EUT PHOTOGRAPHS**

EUT Photo 1

![](_page_33_Picture_5.jpeg)

#### EUT Photo 2

![](_page_33_Picture_7.jpeg)

![](_page_33_Picture_12.jpeg)

![](_page_34_Picture_0.jpeg)

#### **14. EUT TEST PHOTOGRAPHS**

![](_page_34_Picture_4.jpeg)

CE

![](_page_34_Picture_6.jpeg)

![](_page_34_Picture_7.jpeg)

#### **\*\*\*\*\*\* END OF REPORT \*\*\*\*\***

![](_page_34_Picture_13.jpeg)